

Search Notes

Application/Control No.

10/678,445

Examiner

Thien F. Tran

Applicant(s)/Patent under
Reexamination

KLUTH ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
438	261, 287	1/26/2005	TT
438	488, 591	1/26/2005	TT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
438	261, 287	1/26/2005	TT
438	488, 591	1/26/2005	TT

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR